Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/931,021	LEE, CHANG RYUL	
Examiner	Art Unit	_
Ke Xiao	2675	

SEARCHED					
Class	Subclass	Date	Examiner		
345	163,167	2/24/2005	кх		
345	56,157	2/23/2005	кх		
345	160,184	2/22/2005	кх		
341	35	2/22/2005	кх		
715	810,812	2/2/2005	кх		
715	813,856	2/2/2005	кх		
715	859-861	2/2/2005	кх		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted with Supervising Primary Examiner Richard Hjerpe for class and subclass searches.	2/2/2005	кх		
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